## Notice of References Cited Application/Control No. 10/789,504 Examiner Binh X. Tran Applicant(s)/Patent Under Reexamination HSU ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,145,889	09-1992	Wada et al.	523/451
*	В	US-2002/0022681	02-2002	Ichiroku et al.	524/261
*	С	US-2002/0077421	06-2002	Sumita et al.	525/107
*	D	US-2002/0089071	07-2002	Sumita et al.	257/793
*	Е	US-2003/0071368	04-2003	Rubinsztajn, Malgorzata Iwona	257/793
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	7	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

	NON-I ATENT BOOOMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	х							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.